			· · · · ·		Application/Control No.		Reexamination	Applicant(s)/Patent Under Reexamination	
Notice of References Cited					09/896,363			LU ET AL.	
					Examiner		Art Unit	Page 1 of 1	
					Fernando Toledo 2823				
U.S. PATENT DOCUMENTS Document Number Date									
*		Country Code-Number-Kind Code	MM-YYYY	Name				Classification	
	Α	US-6,338,874 B1	01-2002	Law et al.				427/255.18	
	В	US-6,383,913 B1	05-2002	Tsai et al.				438/624	
	С	US-6,177,364 B1	01-2001	Huang, Richard J.				438/792	
	D	US-6,521,524 B1	02-2003	Wang et al.				438/637	
	E	US-6,486,059 B2	11-2002	Lee et al.				438/637	
	F	US-6,429,121 B1	08-2002	Hopper et al.				438/636	
	G	US-2003/0089987 A1	05-2003	PARIKH, SIKETU				257/758	
	Н	US-2002/0171147 A1	11-2002	Yew et al.				257/751	
	ı	US-2002/0027286 A1	03-2002	SUNDARARAJAN et al.				257/751	
	J	US-2003/0077897 A1	04-2003	Tsai et al.			438/633		
	К	US-2002/0106895 A1	08-2002	Chung, Wei-Ming			438/687		
	L	US-							
	М	US-						·	
FOREIGN PATENT DOCUMENTS									
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	(Country Name			Classification	
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	Τ								
NON-PATENT DOCUMENTS									
*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)							
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<u> </u>	-								

"A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.